

# **Notice of References Cited**

Application/Control No.

10/517,472

Applicant(s)/Patent Under  
Reexamination  
HELLMIG ET AL.

Examiner

Henok G. Heyi

Art Unit

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## **U.S. PATENT DOCUMENTS**

* *	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
* A	US-2003/0058777 A1	03-2003	Martynov et al.	369/112.24
B	US-			
C	US-			
D	US-			
E	US-			
F	US-			
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## **FOREIGN PATENT DOCUMENTS**

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## **NON-PATENT DOCUMENTS**

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